Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10714204	ONEDA ET AL.
Examiner	Art Unit
Bayat, Ali	2624

SEARCHED						
Class	Subclass	Date	Examiner			
382	232,233,240,245,246,250,251	1/27/08	A.B			
345	543.1,555	1/27/08	A.B			
375	122	1/27/08	A.B			
341	51	1/27/08	A.B			

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM-TDB; FPRS; USOCR); Inventor name searched; IEEE XPLORE, see text search history print out.	1/27/08	A.B		

INTERFERENCE SEARCH							
Class	Subclass	Date	Examiner				
US-PGPUB	See Interference search history print out.	1/30/08	A.B				

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